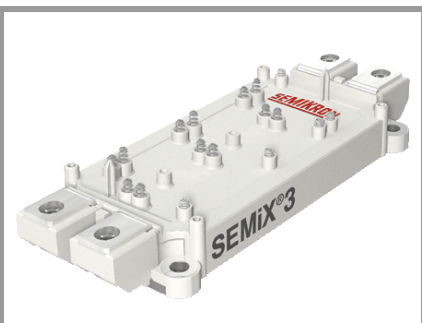


SEMiX603GB066HDs



SEMiX[®]3s

Trench IGBT Modules

SEMiX603GB066HDs

Preliminary Data

Features

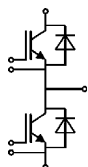
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- UL recognised file no. E63532

Typical Applications

- Matrix Converter
- Resonant Inverter
- Current Source Inverter

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_j=150^\circ\text{C}$
- For short circuit: Soft R_{Goff} recommended
- Take care of over-voltage caused by stray inductance

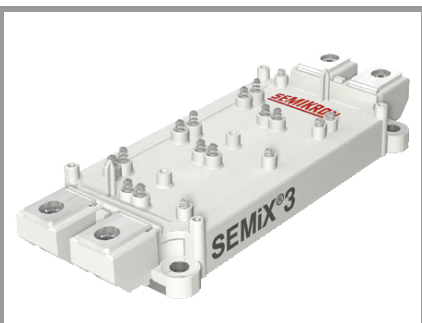


GB

Absolute Maximum Ratings				
Symbol	Conditions	Values	Unit	
IGBT				
V_{CES}		600	V	
I_C	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	720	A
		$T_c = 80^\circ\text{C}$	541	A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	1200	A	
V_{GES}		-20 ... 20	V	
t_{psc}	$V_{CC} = 360\text{V}$ $V_{GE} \leq 15\text{V}$ $T_j = 150^\circ\text{C}$ $V_{CES} \leq 600\text{V}$		6	μs
T_j		-40 ... 175	$^\circ\text{C}$	
Inverse diode				
I_F	$T_j = 175^\circ\text{C}$	$T_c = 25^\circ\text{C}$	771	A
		$T_c = 80^\circ\text{C}$	562	A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	1200	A	
I_{FSM}	$t_p = 10\text{ms}$, half sine wave, $T_j = 25^\circ\text{C}$	1800	A	
T_j		-40 ... 175	$^\circ\text{C}$	
Module				
$I_{t(RMS)}$		600	A	
T_{stg}		-40 ... 125	$^\circ\text{C}$	
V_{isol}	AC sinus 50Hz, $t = 60\text{s}$	4000	V	

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_{Cnom} = 600\text{A}$ $V_{GE} = 15\text{V}$ chiplevel	$T_j = 25^\circ\text{C}$	1.45	1.9	V
		$T_j = 150^\circ\text{C}$	1.70	2.1	V
V_{CE0}		$T_j = 25^\circ\text{C}$	0.9	1	V
		$T_j = 150^\circ\text{C}$	0.85	0.9	V
r_{CE}	$V_{GE} = 15\text{V}$	$T_j = 25^\circ\text{C}$	0.9	1.5	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	1.4	2.0	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE}=V_{CE}$, $I_C = 9.6\text{mA}$	5	5.8	6.5	V
I_{CES}	$V_{GE} = 0\text{V}$ $V_{CE} = 600\text{V}$	$T_j = 25^\circ\text{C}$	0.15	0.45	mA
		$T_j = 150^\circ\text{C}$			mA
C_{ies}	$V_{CE} = 25\text{V}$ $V_{GE} = 0\text{V}$	$f = 1\text{MHz}$	37.0		nF
C_{oes}		$f = 1\text{MHz}$	2.31		nF
C_{res}		$f = 1\text{MHz}$	1.10		nF
Q_G	$V_{GE} = -8\text{V} \dots +15\text{V}$		4800		nC
R_{Gint}	$T_j = 25^\circ\text{C}$		0.67		Ω
$t_{d(on)}$	$V_{CC} = 300\text{V}$		150		ns
t_r	$I_{Cnom} = 600\text{A}$ $T_j = 150^\circ\text{C}$		145		ns
E_{on}		$R_{Gon} = 3\Omega$	12		mJ
$t_{d(off)}$	$R_{Goff} = 3\Omega$		1050		ns
t_f			105		ns
E_{off}			43		mJ
$R_{th(j-c)}$	per IGBT			0.087	K/W

SEMiX603GB066HDs



SEMiX[®]3s

Trench IGBT Modules

SEMiX603GB066HDs

Preliminary Data

Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- UL recognised file no. E63532

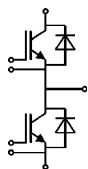
Typical Applications

- Matrix Converter
- Resonant Inverter
- Current Source Inverter

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_j=150^\circ\text{C}$
- For short circuit: Soft R_{Goff} recommended
- Take care of over-voltage caused by stray inductance

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
$V_F = V_{EC}$	$I_{Fnom} = 600\text{A}$ $V_{GE} = 0\text{V}$ chipllevel	$T_j = 25^\circ\text{C}$		1.4	1.6	V
		$T_j = 150^\circ\text{C}$		1.4	1.6	V
V_{F0}		$T_j = 25^\circ\text{C}$	0.9	1	1.1	V
		$T_j = 150^\circ\text{C}$	0.75	0.85	0.95	V
r_F		$T_j = 25^\circ\text{C}$	0.5	0.7	0.8	m Ω
		$T_j = 150^\circ\text{C}$	0.8	0.9	1.1	m Ω
I_{RRM}	$I_{Fnom} = 600\text{A}$	$T_j = 150^\circ\text{C}$		350		A
Q_{rr}	$di/dt_{off} = 3800\text{A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$		63		μC
E_{rr}	$V_{GE} = -8\text{V}$ $V_{CC} = 300\text{V}$	$T_j = 150^\circ\text{C}$		13		mJ
$R_{th(j-c)D}$	per diode				0.11	K/W
Module						
L_{CE}				20		nH
$R_{CC'+EE'}$	res., terminal-chip	$T_C = 25^\circ\text{C}$		0.7		m Ω
		$T_C = 125^\circ\text{C}$		1		m Ω
$R_{th(c-s)}$	per module			0.04		K/W
M_s	to heat sink (M5)		3		5	Nm
M_t	to terminals (M6)		2.5		5	Nm
w					300	g
Temperature sensor						
R_{100}	$T_C=100^\circ\text{C}$ ($R_{25}=5\text{ k}\Omega$)			0,493 $\pm 5\%$		k Ω
$B_{100/125}$	$R_{(T)}=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]$; $T[\text{K}]$;			3550 $\pm 2\%$		K



GB

